

Search Notes**Application/Control No.**

10/531,208

**Applicant(s)/Patent under
Reexamination**

UEDA ET AL.

Examiner

Sin J. Lee

Art Unit

1795

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC structure searches (paper nos. 6, 7, 9 and 10) were reviewed.	6/7/2009	SJL